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**Peter R. Herman
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Contents

v *Conference Committee*

BIOMEDICAL APPLICATIONS FOR ULTRAFAST LASER SYSTEMS I

- 11991 02 **Optimization of processing parameters and conditioning for efficient bone tissue ablation by femtosecond laser** [11991-2]
- 11991 03 **Comparing Bessel-Gauss and Gaussian beams for ultrashort pulsed laser surgery** [11991-1]

BIOMEDICAL APPLICATIONS FOR ULTRAFAST LASER SYSTEMS II

- 11991 04 **Longitudinal multiphoton microscopy of neural structure using a diamond Raman laser and Yb fiber amplifier** [11991-4]

MICROMACHINING OF TRANSPARENT MATERIALS I

- 11991 05 **Integrated fast optical switch fabricated by femtosecond laser micromachining** [11991-16]

NOVEL ULTRAFAST LASER SOURCES

- 11991 06 **Mid-infrared femtosecond pulses from a quantum cascade laser** [11991-20]

MICROMACHINING OF TRANSPARENT MATERIALS II

- 11991 07 **Chamfered-edge laser cleaving of transparent materials** [11991-25]
- 11991 08 **Customized non-diffracting beams for advanced transparent materials processing** [11991-26]
- 11991 09 **Ultrafast laser singulation of optical circuits with optical quality end-facets** [11991-27]

NOVEL PROCESSING AND CHARACTERIZATION TECHNIQUES

- 11991 0A **Remote characterization and delivery of dispersion-compensated ultrashort pulses over dynamic optical fiber links [11991-30]**
- 11991 0B **Space-time division multiplexing-based superfast spectral-domain optical coherence tomography up to 1 MHz A-scan rate [11991-32]**

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